410-LIDAR HANDHELD REFLECTOMETER

Measures reflectance at 850nm, 905nm, 940nm and 1550nm

The 410-LIDAR measures reflectance simultaneously at four key wavelengths employed by lidar systems. Collect measurements on materials and objects that cannot easily be brought into the lab. Fast calibration and measurement times without sacrificing measurement accuracy and repeatability. Option to customize wavelengths.

BENEFITS

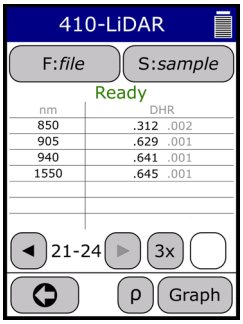
- **4 discrete wavebands**
  850nm, 905nm, 940nm and 1550nm wavelengths.
- **Fast calibration**
  One minute calibration at start of measurement session.
- **One measurement**
  Collects data at all wavebands in a single 7 sec. measurement.
- **Band customization**
  Add or replace stock bands with custom wavelengths.
- **Cleanable calibration coupon**
  Calibration coupon can be wiped clean.
- **Immediate data**
  Touch screen display for data review and management.

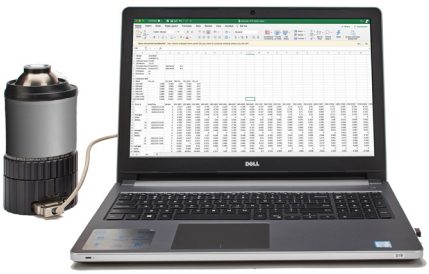
APPLICATIONS

- **Field Measurements**
  Monitor drift in calibrated reflectance values of outdoor targets
- **Lab Measurements**
  In house calibration and reporting at Lidar wavelengths
- **Product qualification**
  LiDAR sensor characterization
- **Large target measurements**
  Measure multiple spots on large lidar calibration targets

EXAMPLE MENU SCREENS

Measurement screen.





ORDERING

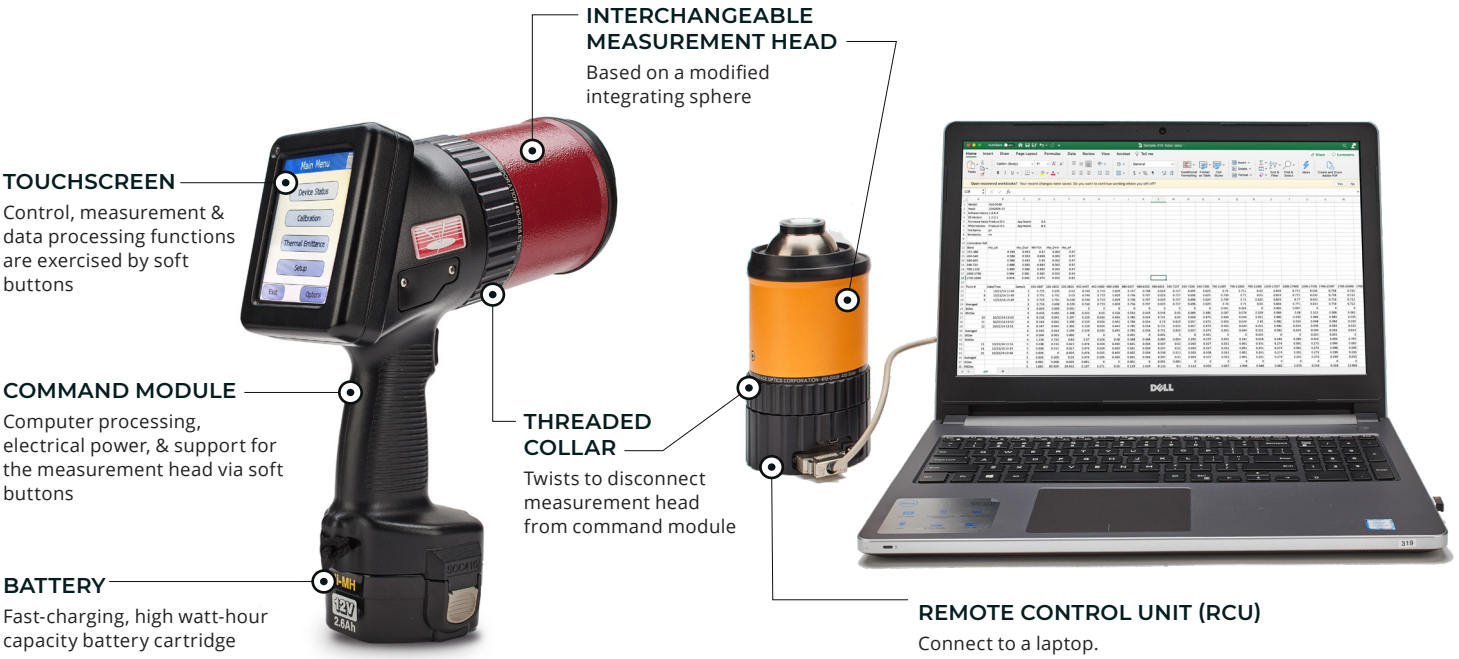
Standard components	0410-0021	410-LiDAR Measurement Head
	0410-0053	Handheld Command Module - 120VAC
	0410-0107	Glazed Ceramic Calibration Coupon (Non-NIST Traceable)
Options	0410-0002	Benchtop Remote Control Unit - 120VAC
	0410-0123	Glazed Ceramic Calibration Coupon (NIST Traceable)
	0410-1016	410-Series Reflectometer Maintenance and Calibration Plan (Non-NIST)
	0410-1009	410-Series Reflectometer Maintenance and Calibration Plan (NIST)
	0410-1019	410-LiDAR Extended Warranty
	0410-0207	SD Card for Extra Data Storage
	0410-0054	Handheld Command Module - 220VAC
	0410-0019	Benchtop Remote Control Unit - 220VAC

CE Equipment described herein is subject to US export regulations and may require a license prior to export. Diversion contrary to US law is prohibited.

SPECIFICATIONS 410-LIDAR

	410-LIDAR
MEASURED DATA	
Measured Parameter	Directional hemispherical reflectance (DHR)
Method	Integrated total reflectance in a band for a given angle of incidence
Measured Value	Absolute reflectance (0-1)
Calculated Value	Total reflectance, absorptance
Wavelength Bands (nm)	850nm, 905nm, 940nm and 1550nm
Angle of Incidence	20° from normal incidence
Calibration Coupon	Glazed Ceramic
PERFORMANCE	
Accuracy	+/- .02
Repeatability	±.005 units
Beam Spot Size	0.50 inches
Measurement Time	7 seconds
Sample Size and Geometry	Flat: ≥ 0.5 in. diameter Curved: 6 in. convex; 12 in. concave
Warm Up Time	90 seconds
Time Between Measurements	2 seconds
Sample temperature	Ambient or heated/cooled to 0 - 100° C
Operating Temperature	0° to 40° C
POWER	
Run Time	2 hours on one battery. Battery easily replaced with continuous operation after battery replacement.
Power Source	Rechargeable battery (standard environmentally friendly NiMH)
Battery Recharge Time	1 hour
VIS-NIR Source	Tungsten filament, temperature controlled by user
DIMENSIONS	
Weight	4.7 lbs. (2.13 kg)
Form Factor/Size	H 11.54 in., L 9.04 in., W 3.27 in. (29.31 cm x 22.96 cm x 9.44 cm)
INTERFACE	
Operator Interface	LCD graphics screen, 1/4 VGA, touch screen, software buttons; trigger switch in handle
Diagnostics	On screen status and signals monitor. Signal values stored with data. Raw data collection and display.
MISCELLANEOUS	
Format	Data files can be opened and post processed with Excel or a text processor
Storage	Removable SanDisk (SD) card
Export control	ECCN #3A999.F

410 SERIES REFLECTOMETERS & EMISSOMETERS



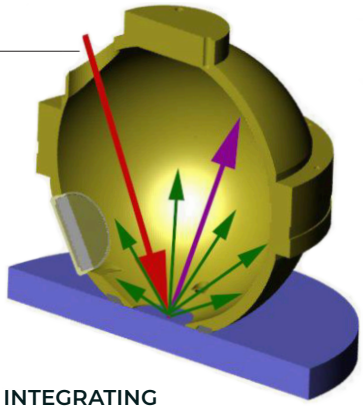
HANDHELD CONFIGURATION **BENCHTOP CONFIGURATION**

METHODOLOGY

The basic structure of a measurement head is an internal source, a modified integrating sphere, and detectors. The reflectance measurement is made by collimating the source beam onto the target, the energy is reflected back into the sphere, and eventually detected or dissipated.

The 410 Series Reflectometers measures the integrated surface reflectance of a surface at a given angle of incidence (20° or 60°). The integrating sphere captures the reflected light from the target material, integrating reflections in all directions. Wavelength-filtered detectors measure the total light reflected in each wavelength band and converts it to an analog electrical signal.

The 410 Series Reflectometer electronics processes the detector signals for initial amplification (fixed), filtering, offset adjustment, secondary amplification (variable), and analog to digital conversion. The digitized signals are read by the on-board processor, stored in memory, and then used to determine the target sample reflectance at each incident angle and wavelength band. Those reflectances are used to calculate additional properties such as directional thermal emittance or total hemispherical emittance. Results are displayed on the liquid crystal display touchscreen, and stored on a SecureDigital (SD) card.



INTEGRATING SPHERE SCHEMATIC

Schematic of the integrating sphere in contact with a sample.

Red arrow – illuminating beam

Purple arrow – reflected beam

Green arrows – scattered light

CALIBRATION COUPON

CALIBRATION

An easy calibration process is required before each measurement session. The software GUI will walk the user through the process. Calibration is performed using calibration coupon(s) with known reflectance values.

410 REFLECTOMETERS MODEL COMPARISON GUIDE

The SOC410 Series Reflectometers are portable contact measurement devices designed to take precise, accurate reflectance and emittance measurements. Made with an ergonomic power-drill design, the SOC410 Series lets you easily take measurements in-the-field or around the lab—no cords or external batteries necessary. The world's largest defense, aerospace, and energy companies rely on SOC410 data.

Model	410-Solar	410-Solar-i	410-LiDAR	ET-100	ET-10	410-DHR
Spectral Bands	335 - 380 nm 400 - 540 nm 480 - 600 nm 590 - 720 nm 700 - 1100 nm 1000 - 1700 nm 1700 - 2500 nm	335 - 380 nm 400 - 540 nm 480 - 600 nm 590 - 720 nm 700 - 1100 nm 1000 - 1700 nm 1700 - 2500 nm	850 nm 905 nm 940 nm 1550 nm	1.5 - 2.0 µm 2.0 - 3.5 µm 3.0 - 4.0 µm 4.0 - 5.0 µm 5.0 - 10.5 µm 10.5 - 21.0 µm	3.0-5.0 µm 8.0-12.0 µm	0.9 - 1.1 µm 1.9 - 2.4 µm 3.0 - 4.0 µm 3.0 - 5.0 µm 4.0 - 5.0 µm 8.0 - 12.0 µm
Calculated Properties	Total, diffuse & specular reflectance absorptance	Total reflectance/ absorptance	Total reflectance/ absorptance	In-band total reflectance Directional thermal emissivity at 20° Directional thermal emissivity at 60° Hemispherical thermal emissivity	Directional thermal emissivity at 20°	In-band total reflectance In-band emissivity
Angle of Incidence	20°	20°	20°	20° and 60°	20°	20° and 60°
Calibration Coupon(s)	Solar Diffuse Solar Specular	Glazed Ceramic	Glazed Ceramic	Specular Gold	Specular Gold	Specular Gold
ASTM Compliance	C1549 E903 E1980	C1549 E903 E1980		E408 E1980		N/A

Also available is the 410-VIS-IR model, a dual measurement head package consisting of the 410-Solar and ET100 measurement heads with a single command module.

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